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P-Channel 25 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	$R_{DS(on)}(\Omega)$ (Max.)	I _D (A)	Q _g (Typ.)			
- 25	$0.024 \text{ at V}_{GS} = -4.5 \text{ V}$	- 29 ^a	23 nC			
- 25	0.035 at $V_{GS} = -2.5 \text{ V}$	- 21 ^a	23110			

Din-Tek

FEATURES

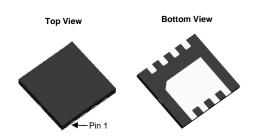
- TrenchFET® Power MOSFET
- Thermally Enhanced DFN3X3 Package
 - Small Footprint Area
 - Low On-Resistance



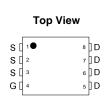
ROHS
COMPLIANT
HALOGEN
FREE

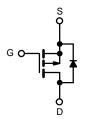
APPLICATIONS

 Load Switch, PA Switch, and Battery Switch for Portable Devices



DFN 3x3 EP





P-Channel MOSFET

Parameter		Symbol	Limit	Unit	
Drain-Source Voltage	V _{DS}	- 25			
Gate-Source Voltage		V_{GS}	± 12	V	
	T _C = 25 °C		- 29 ^a		
Continuous Drain Current (T _{.1} = 150 °C)	T _C = 70 °C	L_	- 18 ^a	А	
Continuous Diam Current (1) = 130 C)	T _A = 25 °C	I _D	- 12 ^{b, c}		
	T _A = 70 °C		- 9 ^{b, c}		
Pulsed Drain Current (t = 300 μs)	I _{DM}	- 80			
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	- 29 ^a		
Continuous Source-Diam Diode Current	T _A = 25 °C	'S	- 12 ^{b, c}		
	T _C = 25 °C		25	W	
Maximum Power Dissipation	T _C = 70 °C	P _D	10		
Maximum Fower Dissipation	T _A = 25 °C	' Б	4.1 ^{b, c}		
	T _A = 70 °C		2.6 ^{b, c}		
Operating Junction and Storage Temperature R	T _J , T _{stg}	- 55 to 150	°C		
Soldering Recommendations (Peak Temperatur		260	C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, f}	t ≤ 5 s	R_{thJA}	22	30	°C/W	
Maximum Junction-to-Case (Drain)	Steady State	R_{thJC}	3.3	4.5	C/VV	

Notes:

- a. Package limited.
- b. Surface mounted on 1" x 1" FR4 board.
- c. t = 2 s
- d. See solder profile The DFN3X3 is a leadless package. The end of the lead terminal is exposed copper (not plated) as a result of the singulation process in manufacturing. A solder fillet at the exposed copper tip cannot be guaranteed and is not required to ensure adequate bottom side solder interconnection.
- e. Rework conditions: manual soldering with a soldering iron is not recommended for leadless components.
- f. Maximum under steady state conditions is 80 °C/W.



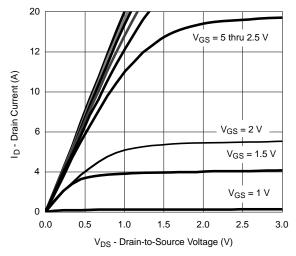
Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static					l.	l	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = -250 \mu\text{A}$	- 25			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J 250A		- 11		m\//00	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = - 250 μA		2.7		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	- 0.5		- 1.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 8 \text{ V}$			± 100	nA	
Zana Oata Walkana Basis Oursest		V _{DS} = - 12 V, V _{GS} = 0 V			- 1	μΑ	
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} = - 12 V, V _{GS} = 0 V, T _J = 55 °C			- 10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \le -5 \text{ V}, V_{GS} = -4.5 \text{ V}$	- 80			Α	
		$V_{GS} = -4.5 \text{ V}, I_D = -5.7 \text{ A}$		0.024	0.027	Ω	
		V _{GS} = - 2.5 V, I _D = - 3.2 A		0.035	0.039		
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = - 1.8 V, I _D = - 2.3 A		0.046	0.051		
		V _{GS} = - 1.5 V, I _D = - 1 A		0.055	0.061		
Forward Transconductance ^a	9 _{fs}	V _{DS} = - 10 V, I _D = - 5.7 A		20		S	
Dynamic ^b					L	l	
Input Capacitance	C _{iss}			1400		pF	
Output Capacitance	C _{oss}	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		280			
Reverse Transfer Capacitance	C _{rss}			190			
Total Cata Channa	Qg	V _{DS} = -6 V, V _{GS} = -8 V, I _D = -10 A		38	57		
Total Gate Charge				23	35	nC	
Gate-Source Charge	Q_{gs}	$V_{DS} = -6 \text{ V}, V_{GS} = -4.5 \text{ V}, I_{D} = -10 \text{ A}$		3			
Gate-Drain Charge	Q_{gd}			6.5			
Gate Resistance	R_g	f = 1 MHz		7		Ω	
Turn-On Delay Time	t _{d(on)}			15	25		
Rise Time	t _r	V_{DD} = - 6 V, R_L = 0.75 Ω		14	24	1	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 8 A, V_{GEN} = - 4.5 V, R_g = 1 Ω		18	30		
Fall Time	t _f			40	60		
Turn-On Delay Time	t _{d(on)}			10	15	ns	
Rise Time	t _r	V_{DD} = - 6 V, R_L = 0.75 Ω		12	20		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong$ - 8 A, V_{GEN} = - 8 V, R_g = 1 Ω		30	50		
Fall Time	t _f			40	60	1	
Drain-Source Body Diode Characterist	ics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			- 29	^	
Pulse Diode Forward Current	I _{SM}				80	A	
Body Diode Voltage	V_{SD}	I _S = -8 A, V _{GS} = 0 V		- 0.8	- 1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			40	60	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = -8 A, di/dt = 100 A/μs, T _J = 25 °C		20	30	nC	
Reverse Recovery Fall Time	t _a	$I_F = -6 \text{ A}, \text{ al/at} = 100 \text{ A/}\mu\text{s}, I_J = 25 ^{\circ}\text{C}$		14			
Reverse Recovery Rise Time	t _b	7		26		ns	

Notes:

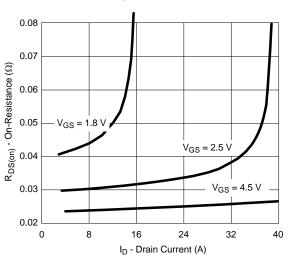
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %. b. Guaranteed by design, not subject to production testing.

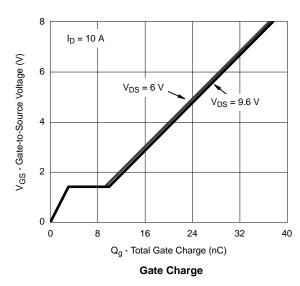


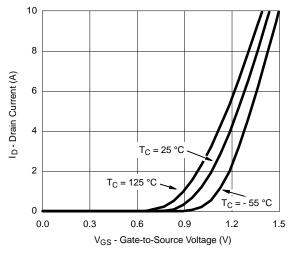


Output Characteristics

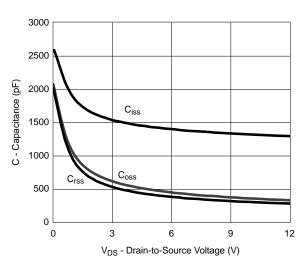


On-Resistance vs. Drain Current and Gate Voltage

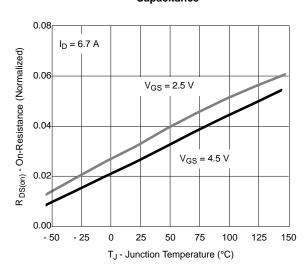




Transfer Characteristics

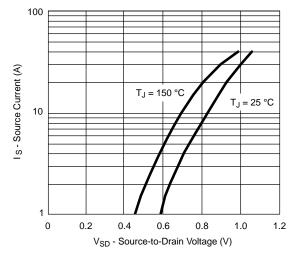


Capacitance

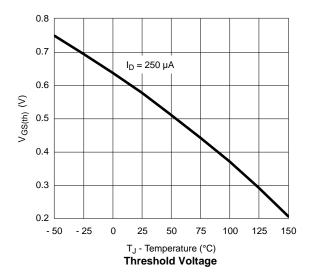


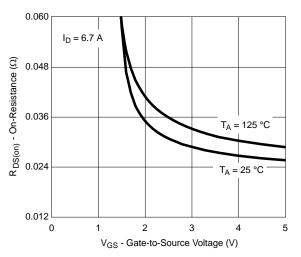
On-Resistance vs. Junction Temperature



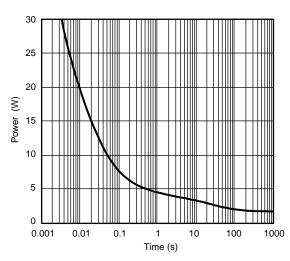


Soure-Drain Diode Forward Voltage

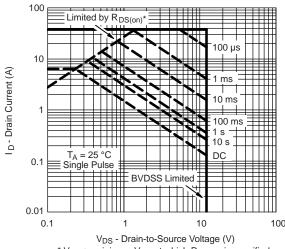




On-Resistance vs. Gate-to-Source Voltage



Single Pulse Power, Junction-to-Ambient

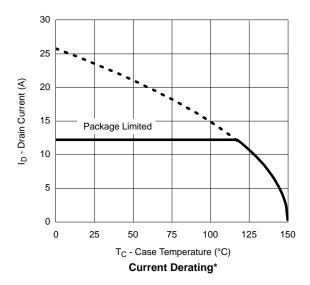


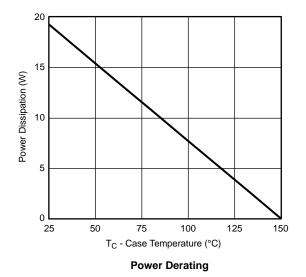
 * $V_{\mbox{\footnotesize{GS}}}$ > minimum $V_{\mbox{\footnotesize{GS}}}$ at which $R_{\mbox{\footnotesize{DS(on)}}}$ is specified

Safe Operating Area, Junction-to-Ambient



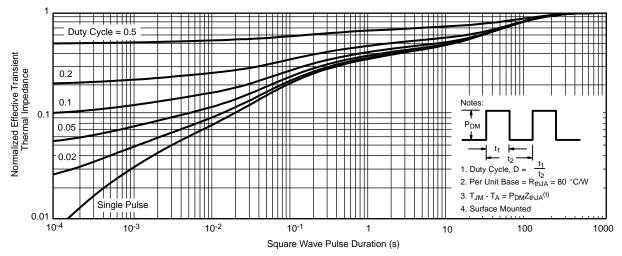




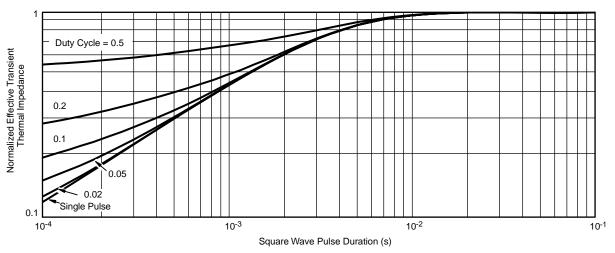


^{*} The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.



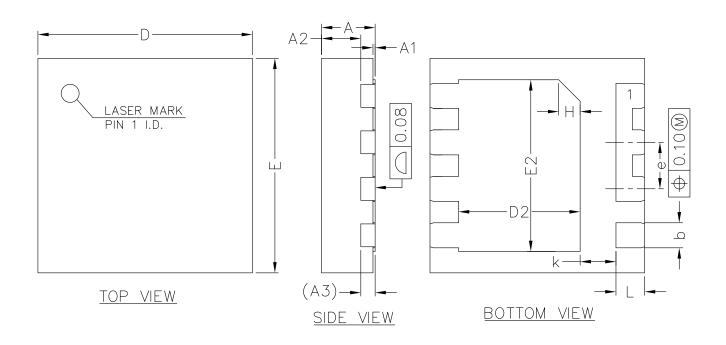


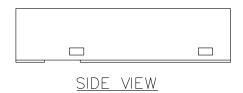
Normalized Thermal Transient Impedance, Junction-to-Ambient



Normalized Thermal Transient Impedance, Junction-to-Case







COMMON DIMENSIONS (UNITS OF MEASURE=MILLIMETER)

SYMBOL	MIN	NOM	MAX	
Α	0.70	0.75	0.80	
A1	0.00	0.02	0.05	
A2	0.50	0.55	0.60	
А3	0.20REF			
b	0.30	0.35	0.40	
D	2.90	3.00	3.10	
E	2.90	3.00	3.10	
D2	1.60	1.70	1.80	
E2	2.30	2.40	2.50	
е	0.55	0.65	0.75	
K	0.40	0.50	0.60	
L	0.35	0.40	0.45	





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